



# N-Channel 8 V (D-S) MOSFET

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	$R_{DS(on)}(\Omega)$	I <sub>D</sub> (A) <sup>a</sup>	Q <sub>g</sub> (Typ.)	
8	$0.047 \text{ at V}_{GS} = 4.5 \text{ V}$	4.0 <sup>a</sup>		
	0.051 at V <sub>GS</sub> = 2.5 V	4.0 <sup>a</sup>	4.24 nC	
	0.058 at V <sub>GS</sub> = 1.8 V	4.0 <sup>a</sup>	4.24 110	
	0.069 at V <sub>GS</sub> = 1.5 V	4.0 <sup>a</sup>		

### **FEATURES**

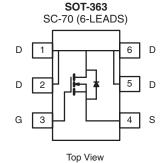
- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET<sup>®</sup> Power MOSFET: 1.5 V Rated
- 100 % R<sub>g</sub> Tested
- Compliant to RoHS Directive 2002/95/EC

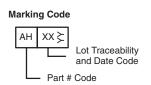


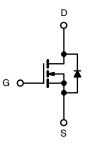


### **APPLICATIONS**

- · Load Switch for Portable Applications
  - Guaranteed Operation at  $V_{GS} = 1.5 \text{ V}$
  - Critical for Optimized Design and Space Savings







Ordering Information: Si1450DH-T1-E3 (Lead (Pb)-free)

Si1450DH-T1-GE3 (Lead (Pb)-free and Halogen-free)

N-Channel MOSFET

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage	V <sub>DS</sub>	8	V		
Gate-Source Voltage		V <sub>GS</sub>	± 5	v	
	T <sub>C</sub> = 25 °C		6.04 <sup>a</sup>		
Continuous Brain Comment (T., 150 °C)	T <sub>C</sub> = 70 °C		4.8 <sup>a</sup>		
Continuous Drain Current (T <sub>J</sub> = 150 °C)	T <sub>A</sub> = 25 °C	I <sub>D</sub>	4.53 <sup>a</sup>		
	T <sub>A</sub> = 70 °C		3.62 <sup>a</sup>	A	
Pulsed Drain Current		I <sub>DM</sub>	15		
Continuous Source-Drain Diode Current	T <sub>C</sub> = 25 °C		2.3		
	T <sub>A</sub> = 25 °C	I <sub>S</sub>	1.3 <sup>c</sup>		
	T <sub>C</sub> = 25 °C		2.78		
Maximum Power Dissipation	T <sub>C</sub> = 70 °C	Б	1.78	144	
	T <sub>A</sub> = 25 °C	P <sub>D</sub>	1.56 <sup>b, c</sup>	W	
	T <sub>A</sub> = 70 °C		1.0 <sup>b, c</sup>		
Operating Junction and Storage Temperature Ra	T <sub>J</sub> , T <sub>stg</sub>	- 55 to 150	°C		
Soldering Recommendations (Peak Temperature	-	260			

THERMAL RESISTANCE RATINGS						
Parameter	Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient <sup>b, f</sup>	t ≤ 5 s	R <sub>thJA</sub>	60	80	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R <sub>thJF</sub>	34	45	- C/VV	

### Notes:

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 5 s.
- d. Maximum under steady state conditions is 125 °C/W.

## Si1450DH

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static	-						
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V, I}_{D} = 250 \mu\text{A}$	8			٧	
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 050 A		8.32		mV/°C	
V <sub>GS(th)</sub> Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	$I_D = 250 \mu\text{A}$		- 2.7			
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	0.3		1	V	
Gate-Source Leakage	I <sub>GSS</sub>	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 5 \text{ V}$			± 100	ns	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 8 V, V <sub>GS</sub> = 0 V			1		
		V <sub>DS</sub> = 8 V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 55 °C			10	μΑ	
On-State Drain Current <sup>a</sup>	I <sub>D(on)</sub>	$V_{DS} \le 5 \text{ V}, V_{GS} = 4.5 \text{ V}$	15			Α	
		$V_{GS} = 4.5 \text{ V}, I_D = 4.0 \text{ A}$		0.039	0.047	Ω	
Dunin Course On Chata Basistanas		$V_{GS} = 2.5 \text{ V}, I_D = 4.0 \text{ A}$		0.042	0.051		
Drain-Source On-State Resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = 1.8 V, I <sub>D</sub> = 4.0 A		0.048	0.058		
		V <sub>GS</sub> = 1.5 V, I <sub>D</sub> = 1.28 A		0.053	0.069		
Forward Transconductance <sup>a</sup>	9 <sub>fs</sub>	$V_{DS} = 4 \text{ V}, I_{D} = 4.0 \text{ A}$		15.5		S	
Dynamic <sup>b</sup>							
Input Capacitance	C <sub>iss</sub>			535		pF	
Output Capacitance	C <sub>oss</sub>	$V_{DS} = 4 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		120			
Reverse Transfer Capacitance	C <sub>rss</sub>			61			
Total Cata Charge		V <sub>DS</sub> = 4 V, V <sub>GS</sub> = 5 V, I <sub>D</sub> = 4.0 A		4.7	7.05	nC	
Total Gate Charge	Qg			4.24	6.4		
Gate-Source Charge	$Q_{gs}$	$V_{DS} = 4 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 4.0 \text{ A}$		1.2			
Gate-Drain Charge	Q <sub>gd</sub>			0.810			
Gate Resistance	R <sub>g</sub>	f = 1 MHz		7.3	11	Ω	
Turn-On Delay Time	t <sub>d(on)</sub>			8	12		
Rise Time	t <sub>r</sub>	$V_{DD} = 4 \text{ V, R}_{L} = 1.11 \Omega$		73	110	ns	
Turn-Off Delay Time	t <sub>d(off)</sub>	$I_D \cong 3.6 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		18	27		
Fall Time	t <sub>f</sub>			5	7.5		
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I <sub>S</sub>	T <sub>C</sub> = 25 °C			2.6	^	
Pulse Diode Forward Current	I <sub>SM</sub>				15	A	
Body Diode Voltage	V <sub>SD</sub>	I <sub>S</sub> = 2.6 A, V <sub>GS</sub> = 0 V		0.8	1.2	V	
Body Diode Reverse Recovery Time	t <sub>rr</sub>			14.3	21.45	ns	
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	$I_F = 2.6 \text{ A, dI/dt} = 100 \text{ A/}\mu\text{s, T}_J = 25 ^{\circ}\text{C}$		3.6	5.4	nC	
Reverse Recovery Fall Time	t <sub>a</sub>			6.8		ns	
Reverse Recovery Rise Time	t <sub>b</sub>			7.5			

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

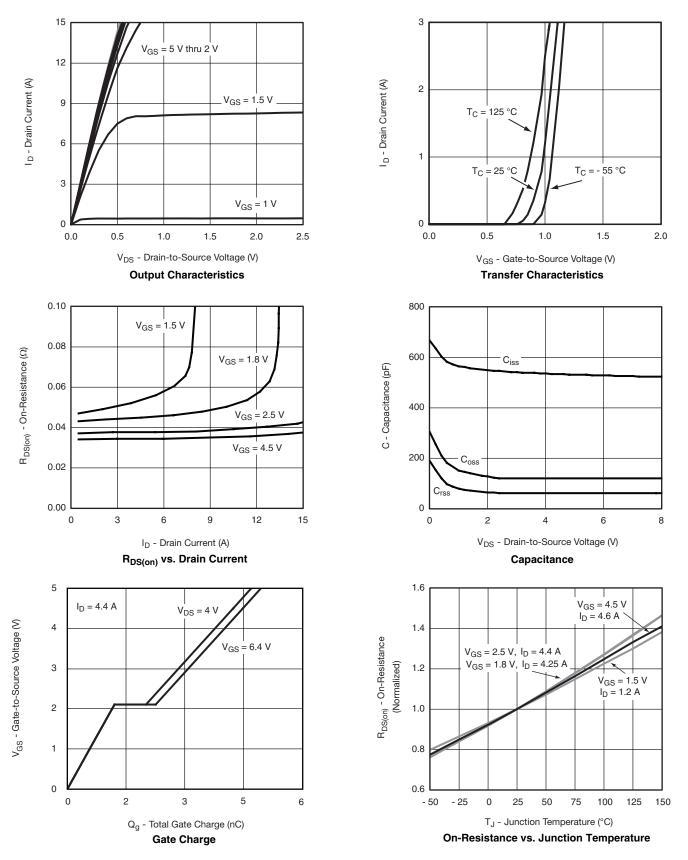
Notes: a. Pulse test; pulse width  $\leq$  300  $\mu$ s, duty cycle  $\leq$  2 %. b. Guaranteed by design, not subject to production testing.





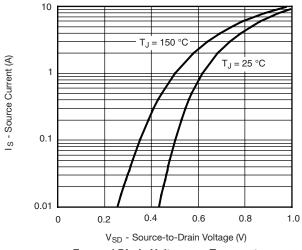


### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

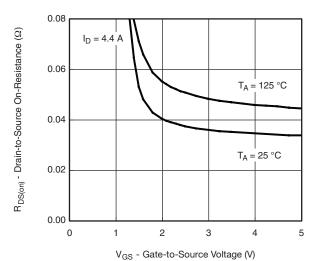


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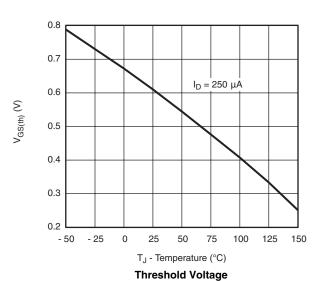
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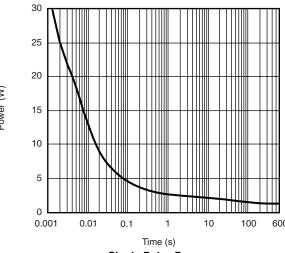
Forward Diode Voltage vs. Temperature



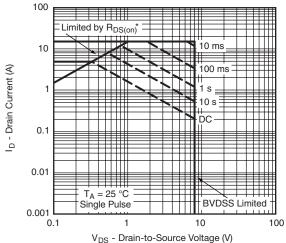
R<sub>DS(on)</sub> vs. V<sub>GS</sub> vs. Temperature



Power (W)



Single Pulse Power



 $^{\star}\,V_{GS}>$  minimum  $V_{GS}$  at which  $R_{DS(on)}$  is specified

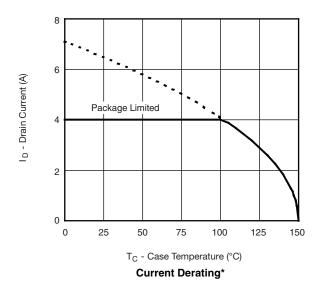
Safe Operating Area, Junction-to-Case

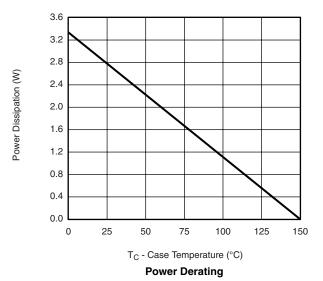






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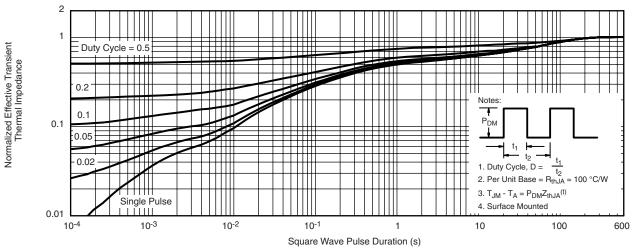


<sup>\*</sup> The power dissipation  $P_D$  is based on  $T_{J(max)} = 150$  °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package

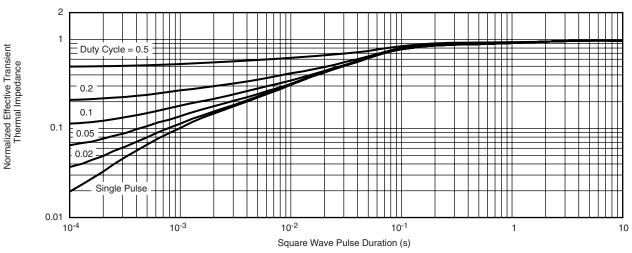
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### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



### Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

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